DECLARATION

As a below named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated below next to my name.

I believe I am the original, first and sole inventor (if only one name is listed below) or the below named inventors are the original, first and joint inventors (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled "METHOD OF MEASURING IMPLANT PROFILES USING SCATTEROMETRIC TECHNIQUES" the Specification of which:

	is attached was filed		as Application Ser	ial No					
includin	I hereby state thag the claims.	t I have review	ed and understan	d the contents of	the above-identified specif	ication,			
	_	he subject matter			all information known to mriality" is defined in Title 3				
I hereby claim priority benefits under Title 35, United States Code, § 119 of any foreign application(s) for patent, United States provisional application(s), or inventor's certificate listed below and have also identified below any foreign application for patent, United States provisional application, or inventor's certificate having a filing date before that of the application on which priority is claimed:									
		PRIORITY	APPLICATION	N(S)	Priority Claimed				
(Numb	per)	(Country)		Date Filed)	Yes/No				
(Numb	per)	(Country)	(Date Filed)	Yes/No				
United Sacknowl claimed	elow and, insofar as States application in ledge the duty to di in this application available between t	the subject mate the manner pro- sclose all inform , as "materiality	er of each of the ovided by the first ation known to not it is defined in T	claims of this applit paragraph of Title to be material to itle 37, Code of Fe	of any United States application is not disclosed in the 35, United States Code, § patentability of the subject ederal Regulations, § 1.56, or PCT international filing	ne prior § 112, I t matter, which			
	(Application Seria	l No.) (F	iling Date)	(Status)					
	(Application Seria	l No.) (F	iling Date)	(Status)					

I hereby direct that all correspondence and telephone calls be addressed to J. Mike Amerson, Williams, Morgan & Amerson, P.C., 7676 Hillmont, Suite 250, Houston, Texas 77040, (713) 934-4055.

I HEREBY DECLARE THAT ALL STATEMENTS MADE OF MY OWN KNOWLEDGE ARE TRUE AND THAT ALL STATEMENTS MADE ON INFORMATION AND BELIEF ARE BELIEVED TO BE TRUE; AND FURTHER THAT THESE STATEMENTS WERE MADE WITH THE KNOWLEDGE THAT WILLFUL FALSE STATEMENTS AND THE LIKE SO MADE ARE PUNISHABLE BY FINE OR IMPRISONMENT, OR BOTH, UNDER SECTION 1001 OF TITLE 18 OF THE UNITED STATES CODE AND THAT SUCH WILLFUL FALSE STATEMENTS MAY JEOPARDIZE THE VALIDITY OF THE APPLICATION OR ANY PATENT ISSUED THEREON.

Inventor's Full Name:	JAMES BROC STIRTON		
Inventor's Signature:	James Bric State		
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(if different from above)			
	The state of the s	······································	

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: JAMES BROC STIRTON Examiner: Unknown Serial No.: Unknown Group Art Unit: Unknown Filed: Concurrently Herewith Att'y Docket: 2000.071000/TT4354 § § For: METHOD OF MEASURING IMPLANT PROFILES USING SCATTEROMETRIC **TECHNIQUES** §

POWER OF ATTORNEY

Assistant Commissioner for Patents Washington, D.C. 20231

Sir:

The undersigned, being the inventor named in the above-identified application, hereby revokes any previous Powers of Attorney and appoints:

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as its attorney or agent so long as they remain with such firms, with full power of substitution and revocation, to prosecute the application, to make alterations and amendments therein, to transact all business in the Patent and Trademark Office in connection therewith, and to receive any Letters Patent, and for one year after issuance of such Letters Patent to file any request for a certificate of correction that may be deemed appropriate.

Please direct all communications as follows:

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